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C-Si photovoltaic (PV) modules — Light and elevated temperature induced degradation (LETID) test — Detection

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The UK participation in its preparation was entrusted to Technical Committee GEL/82, Photovoltaic Energy Systems.

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ISBN 978 0 539 15510 5

ICS 27.160

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This Published Document was published under the authority of the Standards Policy and Strategy Committee on 30 September 2022.

Amendments/corrigenda issued since publication

Date	Text affected

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IEC TS 63342

Edition 1.0 2022-07

TECHNICAL SPECIFICATION

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C-Si photovoltaic (PV) modules – Light and elevated temperature induced degradation (LETID) test – Detection

INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

ICS 27.160

ISBN 978-2-8322-3977-3

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

C-SI PHOTOVOLTAIC (PV) MODULES – LIGHT AND ELEVATED TEMPERATURE INDUCED DEGRADATION (LETID) TEST – DETECTION

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IEC TS 63342 has been prepared by IEC technical committee 82: Solar photovoltaic energy systems. It is a Technical Specification.

The text of this Technical Specification is based on the following documents:

Draft	Report on voting
82/2008/DTS	82/2044/RVDTS

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this Technical Specification is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/standardsdev/publications.

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